

LM5050-2

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LM5050-2 High Side OR-ing FET Controller

Check for Samples: LM5050-2

FEATURES

- Wide Operating Input Voltage Range: +6V to +75V
- +100 Volt Transient Capability
- Charge Pump Gate Driver for External N-Channel MOSFET
- MOSFET Diagnostic Test Mode
- Fast 50ns Response to Current Reversal
- 2A Peak Gate Turn-off Current
- Minimum V_{DS} Clamp for Faster Turn-off
- Package: SOT-6 (Thin SOT23-6)

APPLICATIONS

 Active OR-ing of Redundant (N+1) Power Supplies

Typical Application Circuits

DESCRIPTION

The LM5050-2 High Side OR-ing FET Controller operates in conjunction with an external MOSFET as an ideal diode rectifier when connected in series with a power source. This OR-ing controller allows MOSFETs to replace diode rectifiers in power distribution networks thus reducing both power loss and voltage drops.

The LM5050-2 controller provides charge pump gate drive for an external N-Channel MOSFET and a fast response comparator to turn off the FET when current flows in the reverse direction. The LM5050-2 can connect power supplies ranging from +6V to +75V and can withstand transients up to +100V.

The LM5050-2 also provides a FET test diagnostic mode which allows the system controller to test for shorted MOSFETs.

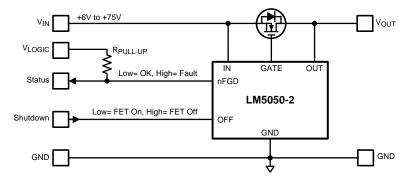
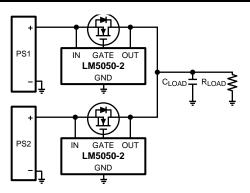


Figure 1. Full Application with MOSFET Diagnostic

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Connection Diagram

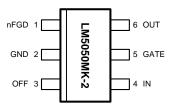


Figure 3. LM5050MK-2 SOT-6 Package (Top View)

PIN DESCRIPTIONS

Pin #	Name	Function		
1	nFGD	Open drain output for the FET Test circuit. Status pin used in conjunction with the OFF test mode pin. When the OFF pin is in the logic high state, an active low state on nFGD indicates that the forward voltage (from source to drain) of the external MOSFET is greater than 350 mV. The nFGD pin requires an external pull-up resistor to a voltage not higher than 5.5V.		
2	GND	Ground return for the controller		
3	FET Test Mode control input. Logic low or oper will deactivate the FET Test Mode. A logic hig pull the GATE pin low and turn off the external diode forward voltage of the MOSFET (from s than 350mV when the OFF pin is in the high s indicate that the MOSFET is not shorted by pr state.			
4	IN	Voltage sense connection to the external MOSFET Source pin and supply input to the internal charge pump.		
5	GATE	Connection to the external MOSFET Gate.		
6	OUT	Voltage sense connection to the external MOSFET Drain pin and supply pin for biasing the internal control circuitry.		



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



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Absolute Maximum Ratings (1)(2)

-0.3V to 100V
-0.3V to 100V
-0.3V to 7V
-0.3V to 7V
−65°C to 150°C
2 kV 150V
260°C, 30sec

(1) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur, including in-operability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. Operating Range conditions indicate the conditions at which the device is functional and the device should not be operated beyond such conditions. For specifications and conditions, see Electrical Characteristics.

(3) The GATE pin voltage is typically 12V above the IN pin voltage when the LM5050-2 is enabled (i.e. OFF Pin is Open or Low, and V_{IN} > V_{OUT}). Therefore, the Absolute Maximum Rating for the IN pin voltage applies only when the LM5050-2 is disabled (i.e. OFF Pin is logic high), or for a momentary surge to that voltage since the Absolute Maximum Rating for the GATE pin is also 100V

(4) The Human Body Model (HBM) is a 100 pF capacitor discharged through a 1.5 kΩ resistor into each pin. Applicable test standard is JESD-22-A114-C.

(5) The Machine Model (MM) is a 200 pF capacitor discharged through a 0Ω resistor (i.e. directly) into each pin. Applicable test standard is JESD-A115-A.

(6) For soldering specifications visit www.ti.com.

Operating Ratings ⁽¹⁾

IN, OUT Pins	+6.0V to +75V
OFF Pin Voltage	0.0V to 5.5V
nFGD Voltage (Off)	0.0V to 5.5V
nFGD Sink Current (On)	0 mA to 1 mA
Junction Temperature Range (T _J)	−40°C to +125°C

(1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur, including in-operability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. Operating Range conditions indicate the conditions at which the device is functional and the device should not be operated beyond such conditions. For specifications and conditions, see Electrical Characteristics.



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Electrical Characteristics

Limits in standard type are for $T_J = 25^{\circ}$ C only; limits in **boldface type** apply over the operating junction temperature (T_J) range of -40°C to +125°C. Minimum and Maximum limits are specified through test, design, or statistical correlation. Typical values represent the most likely parametric norm at T_J = 25°C, and are provided for reference purposes only. Unless otherwise stated the following conditions apply: $V_{IN} = 12.0V$, $V_{OUT} = 12.0V$, $V_{OFF} = 0.0V$, $C_{GATE} = 47$ nF, and $T_J = 25^{\circ}C$.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
l Pin							
V _{IN}	Operating Supply Range		6.0	-	75.0	V	
		$V_{IN} = 6.0V$ GATE = Open $V_{OUT} = V_{IN} - 100 \text{ mV}$	180	240	300		
I _{IN}	IN Pin current	$V_{IN} = 12.0V$ GATE = Open $V_{OUT} = V_{IN} - 100 \text{ mV}$	262	350	440	μA	
		$V_{IN} = 75.0V$ GATE = Open $V_{OUT} = V_{IN} - 100 \text{ mV}$	275	355	460		
UT Pin							
		$V_{IN} = 6.0V$ $V_{OUT} = V_{IN} - 100 \text{ mV}$	74	95	115		
I _{OUT}	OUT Pin Current		70	110	160	uA	
		V _{IN} = 75.0V V _{OUT} = V _{IN} - 100 mV	35	5 125 26		1	
ATE Pin							
I _{GATE(ON)}	GATE Pin Source Current		18.0	32.	45.0	uA	
		$V_{IN} = 6.0V$ $V_{OUT} = V_{IN} - 175 \text{ mV}$	6.0	6.8	7.4		
V _{GS}	V_{GATE} - V_{IN} in Forward Operation ⁽¹⁾	V _{IN} = 12.0V V _{OUT} = V _{IN} - 175 mV	8.0	11.5	14.7	V	
		$V_{IN} = 75.0V$ $V_{OUT} = V_{IN}$ - 175 mV	8.0	11	14.5		
	Gate Capacitance Discharge Time at	$C_{GATE} = 0^{(2)}$	-	27	100		
t _{GATE(REV)}	Forward to Reverse Transition	C_{GATE} = 10 nF ⁽²⁾	-	61	-	ns	
	See Figure 4	C_{GATE} = 47 nF ⁽²⁾	-	205	425		
t _{GATE(OFF)}	Gate Capacitance DischargeTime at OFF pin Low to High Transition See Figure 5	C_{GATE} = 47 nF ⁽³⁾	-	450	-	ns	
I _{GATE(OFF)}	GATE Pin Sink Current	$V_{GATE} = V_{IN} + 3V$ $V_{OUT} > V_{IN} + 100 \text{ mV}$ $t \le 10\text{ms}$	1.9	2.8	-	A	
V _{SD(REV)}	Reverse V_{SD} Threshold $V_{IN} < V_{OUT}$	V _{IN} - V _{OUT}	-37	-27	-17	mV	
$\Delta V_{SD(REV)}$	Reverse V _{SD} Hysteresis		-	10	-	mV	
	Regulated Forward V _{SD} Threshold	$V_{IN} = 6.0V$ $V_{IN} - V_{OUT}$	6	20	33	mV	
$V_{SD(REG)}$	V _{IN} > V _{OUT}	V _{IN} = 12.0V V _{IN} - V _{OUT}	2	16	31	IIIV	

(1)

Measurement of V_{GS} voltage (i.e. V_{GATE} - V_{IN}) includes 1 M Ω in parallel with C_{GATE} Time from V_{IN}-V_{OUT} voltage transition from 200mV to -500mV until GATE pin voltage falls to V_{IN} + 1V. See Figure 4 Time from V_{OFF} voltage transition from 0.0V to 5.0V until GATE pin voltage falls to V_{IN} + 1V. See Figure 5 (2)

(3)

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Electrical Characteristics (continued)

Limits in standard type are for $T_J = 25^{\circ}$ C only; limits in **boldface type** apply over the operating junction temperature (T_J) range of -40°C to +125°C. Minimum and Maximum limits are specified through test, design, or statistical correlation. Typical values represent the most likely parametric norm at $T_J = 25^{\circ}$ C, and are provided for reference purposes only. Unless otherwise stated the following conditions apply: $V_{IN} = 12.0V$, $V_{OUT} = 12.0V$, $V_{OFF} = 0.0V$, $C_{GATE} = 47$ nF, and $T_J = 25^{\circ}$ C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
OFF Pin						
V _{OFF(IH)}	OFF Input High Threshold Voltage	V _{OUT} = V _{IN} -500 mV V _{OFF} Rising	-	1.55	1.73	v
V _{OFF(IL)}	OFF Input Low Threshold Voltage	V _{OUT} = V _{IN} - 500 mV V _{OFF} Falling	1.09	1.41	-	
ΔV_{OFF}	OFF Threshold Voltage Hysteresis	V _{OFF(IH)} - V _{OFF(IL)}	-	160	-	mV
I _{OFF}	OFF Pin Internal Pull-down	V _{OFF} = 5.0V	2.0	5	8.0	μA
FGD Pin						
V _{SD(TST)}	FET Test Threshold Voltage $V_{IN} < V_{OUT}$	$V_{OFF} = 5V$ $V_{OUT} = 12V$ V_{IN} falling from 12V	250	350	450	mV
$\Delta V_{SD(TST)}$	FET Test Threshold Voltage Hysteresis		-	95	-	mV
nFGD _{VOL}	nFGD Output Low Voltage nFGD Output = On	V _{OFF} = 5V I _{nFGD} = 1 mA Sinking	-	630	850	mV
nFGD _{IOL}	nFGD Output Leakage Current nFGD Output = Off	$V_{OFF} = 0V$ $V_{nFGD} = 5.5V$	-	0.001	0.7	μA

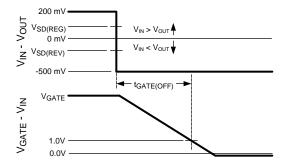


Figure 4. Gate Off Timing for Forward to Reverse Transition



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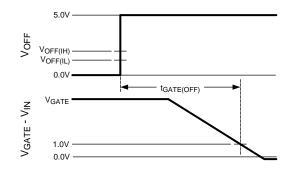
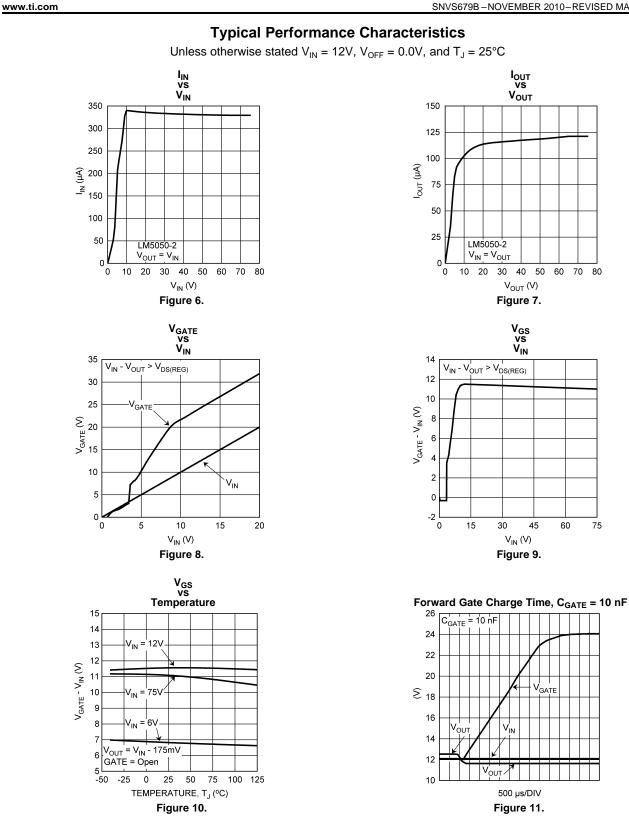


Figure 5. Gate Off Timing for OFF pin Low to High Transition





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Typical Performance Characteristics (continued) Unless otherwise stated $V_{\rm IN}$ = 12V, $V_{\rm OFF}$ = 0.0V, and $T_{\rm J}$ = 25°C Forward Gate Charge Time, C_{GATE} = 47 nF Reverse C_{GATE} Discharge 26 26 C_{GATE} = 47 nF C_{GATE} = 10 nF 24 24 22 22 20 20 GATE Ξ₁₈ Σ₁₈ 16 16 ν_{ιν} Vout 14 14 12 12 VOUT 10 10 2 ms/DIV 100 µs/DIV Figure 12. Figure . **OFF Pin Thresholds** t_{GATE(REV)} VS vs Temperature Temperature 350 $C_{GATE} = 47 \text{ nF}$ 1.9 300 1.8 1.7 1.6 1.5 1.4 1.5 1.4 1.3 1.3 OFF 250 V_{OFF(IH)} t_{GATE(REV)} (ns) 200 ΔV_{OFF} 150 V_{OFF(IL)}/ 100 ON 1.2 50 1.1 0 1.0 -50 -25 0 25 50 75 100 125 -50 -25 0 25 50 75 100 125 TEMPERATURE, T_J (°C) TEMPERATURE, T_J (°C) Figure 13. Figure 14. C_{GATE} Charge and Discharge **OFF Pin Pull-Down** vs V_{OUT} vs OFF Pin 8 25 V_{IN} = V_{OUT} C_{GATE} = 10 nF 7 V_{OFF} = 5.5V 20 Agree (V) 20 V_{GATE} (V) 6 V_{GATE} 5 15 I_{OFF} (µA) 4 10 3 2 V_{OFF} (V) Ę VOFF 1 0 L 0 0 15 30 45 60 75 1 ms/DIV $V_{OUT}(V)$ Figure 15. Figure 16.

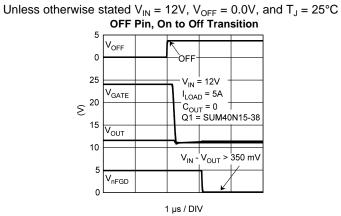
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Typical Performance Characteristics (continued)





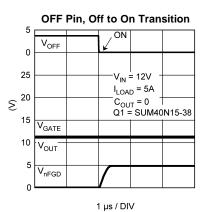
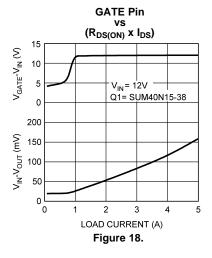


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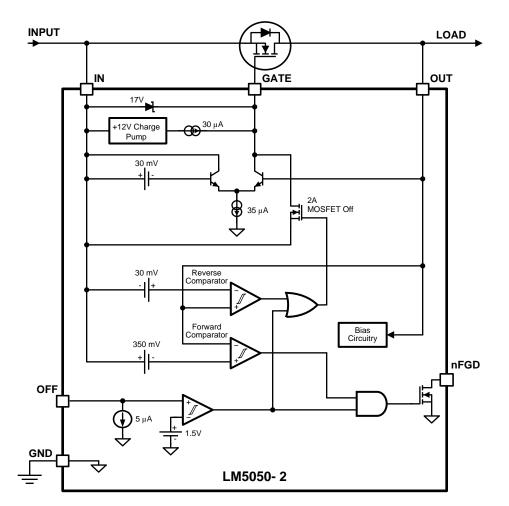


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APPLICATIONS INFORMATION

FUNCTIONAL DESCRIPTION

Systems that require high availability often use multiple, parallel-connected redundant power supplies to improve reliability. Schottky OR-ing diodes are typically used to connect these redundant power supplies to a common point at the load. The disadvantage of using OR-ing diodes is the forward voltage drop, which reduces the available voltage, and the associated power losses as load currents increase. Using an N-channel MOSFET to replace the OR-ing diode requires a small increase in the level of complexity, but reduces, or eliminates, the need for diode heat sinks or large thermal copper area in circuit board layouts for high power applications.

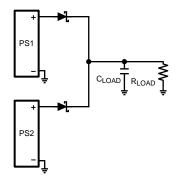


Figure 19. Traditional OR-ing with Diodes

The LM5050-2 is a positive voltage (i.e. high-side) OR-ing controller that will drive an external N-channel MOSFET to replace an OR-ing diode. The voltage across the MOSFET source and drain pins is monitored by the LM5050-2 at the IN and OUT pins, while the GATE pin drives the MOSFET to control its operation based on the monitored source-drain voltage. The resulting behavior is that of an ideal rectifier with source and drain pins of the MOSFET acting as the anode and cathode pins of a diode respectively.

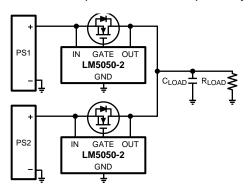


Figure 20. OR-ing with MOSFETs

IN, GATE AND OUT PINS

When power is initially applied, the load current will flow from source to drain through the body diode of the MOSFET. The resulting voltage across the body diode will be detected at the LM5050-2 IN and OUT pins which then begins charging the MOSFET gate through a 30 μ A (typical) charge pump current source . In normal operation, the gate of the MOSFET is charged until it reaches typically 12V above the IN pin. With an IN pin voltage that is less than approximately 10V, the gate of the MOSFET is charged to typically twice the voltage on the IN pin.

The LM5050-2 is designed to regulate the MOSFET gate-to-source voltage if the voltage across the MOSFET source and drain pins falls below the $V_{SD(REG)}$ voltage of 27 mV (typical).

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If the MOSFET current decreases to the point that the voltage across the MOSFET falls below the $V_{SD(REG)}$ voltage regulation point of 27 mV (typical), the GATE pin voltage will be decreased until the voltage across the MOSFET is regulated at 27 mV. If the drain-to-source voltage is greater than $V_{SD(REG)}$ voltage the gate-to-source will increase, eventually reaching the 12V GATE to IN zener clamp level.

If the MOSFET current reverses, possibly due to failure of the input supply, such that the voltage across the LM5050-2 IN and OUT pins is more negative than the $V_{SD(REV)}$ voltage of -27 mV (typical), the LM5050-2 will quickly discharge the MOSFET gate through a strong GATE to IN pin discharge transistor.

If the input supply fails abruptly, as would occur if the supply was shorted directly to ground, a reverse current will temporarily flow through the MOSFET until the gate can be fully discharged. This reverse current is sourced from the output load capacitance and from the parallel connected supplies. The LM5050-2 responds to a voltage reversal condition typically within 27 ns. The actual time required to turn off the MOSFET will depend on the charge held by gate capacitance of the MOSFET being used. A MOSFET with 47 nF of effective gate capacitance can be turned off in typically 205 ns. This fast turn off time minimizes voltage disturbances at the output, as well as the current transients from the redundant supplies.

OFF PIN and nFGD PIN

The OFF pin is a logic level input pin that is used to control the gate drive to the external MOSFET in the FET Test Mode. The maximum operating voltage on this pin is 5.5V. The nFGD pin is an open drain output pin that supports a logic level voltage. The maximum operating voltage on this pin is 5.5V.

When the OFF pin is high, the MOSFET is turned off (independent of the sensed IN and OUT voltages) and the FET Test Mode is activated. In this mode, load current will flow through the body diode of the MOSFET. The voltage difference between the IN pin and OUT pins will be approximately 700 mV if the MOSFET is operating normally through the body diode. The FET test comparator of the LM5050-2 monitors the IN to OUT pin voltage difference with a $V_{SD(TST)}$ threshold of 350 mV (typical). If the IN pin to OUT pin voltage difference is greater than this threshold, the nFGD pin will switch to a low impedance state and the nFGD pin voltage will be at a logic low. If the MOSFET is shorted, the voltage difference between the IN pin and the OUT pin will be less than the $V_{SD(TST)}$ threshold. In this case, the nFGD pin will remain in a high impedance state and the pin voltage can be pulled high by an external pull-up resistor.

In normal operation the OFF pin must be pulled low (or left open). In this mode, the GATE pin voltage will depend upon the forward or reverse voltage across the MOSFET source to drain as previously described.

The OFF pin has an internal pull-down of 5 µA (typical). If the OFF function is not required, the pin may be left open or connected to ground.

While the OFF pin is low the nFGD pin will always be in a high impedance open state.

Several factors can prevent the nFGD pin from indicating that the external MOSFET is operating normally. If the LM5050-2 is used to connect parallel, redundant power supplies, one of the connected supplies may hold the OUT pin voltage close enough to the LM5050-2 IN pin voltage that the $V_{SD(TST)}$ threshold is not exceeded. Additionally, operating with a high output capacitance value and low load current may require a significant amount of time before the output capacitance is discharged to the point where the $V_{SD(TST)}$ threshold is exceeded and the nFGD pin switches low.

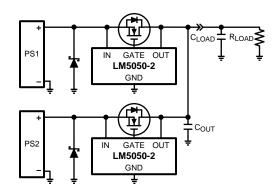
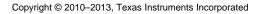


Figure 21. Typical Connection



SHORT CIRCUIT FAILURE OF AN INPUT SUPPLY

An abrupt zero ohm short circuit across the input supply will cause the highest possible reverse current to flow while the internal LM5050-2 control circuitry discharges the gate of the MOSFET. During this time, the reverse current is limited only by the $R_{DS(ON)}$ of the MOSFET, along with parasitic wiring resistances and inductances. Worst case instantaneous reverse current would be limited to:

$$D_{(\text{REV})} = (V_{\text{OUT}} - V_{\text{IN}}) / R_{\text{DS(ON)}}$$

The internal Reverse Comparator will react, and will start the process of discharging the Gate, when the reverse current reaches:

$$D_{(REV)} = V_{SD(REV)} / R_{DS(ON)}$$

When the MOSFET is finally switched off, the energy stored in the parasitic wiring inductances will be transferred to the rest of the circuit. As a result, the LM5050-2 IN pin will see a negative voltage spike while the OUT pin will see a positive voltage spike. The IN pin can be protected by diode clamping the pin to GND in the negative direction. The OUT pin can be protected with a TVS protection diode, a local bypass capacitor, or both. In low voltage applications, the MOSFET drain-to-source breakdown voltage rating may be adequate to protect the OUT pin (i.e. $V_{IN} + V_{(BR)DSS(MAX)} < 75V$), but most MOSFET datasheets do not specifiy the maximum breakdown rating, so this method should be used with caution.

Reverse Recovery Current

ЪГ

GND

GATE OUT

Parasitic Inductance

COUT

<u>````__</u>

CLOAD

Parasitic

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Figure 22. Input Supply Fault Transients

| OFF<br>Pin     | Mode                | FET<br>Gate<br>Drive | V <sub>IN</sub> - V <sub>OUT</sub> | FET<br>Status | nFGD<br>Pin<br>Status  | nFGD<br>Pin<br>Voltage |       |     |
|----------------|---------------------|----------------------|------------------------------------|---------------|------------------------|------------------------|-------|-----|
| Low or<br>Open | Normal<br>Operation | Active               |                                    | -             | High Z                 | High                   |       |     |
| Lliab          |                     |                      | High FET Test Off                  |               | > V <sub>SD(TST)</sub> | ОК                     | Low Z | Low |
| High           | FEITest             | Off                  | < V <sub>SD(TST)</sub>             | Not OK        | High Z                 | High                   |       |     |

#### **MOSFET SELECTION**

The important MOSFET electrical parameters are the maximum continuous Drain current I<sub>D</sub>, the maximum Source current (i.e. body diode), the maximum drain-to-source voltage  $V_{DS(MAX)}$ , the gate-to-source threshold voltage  $V_{GS(TH)}$ , the drain-to-source reverse breakdown voltage  $V_{(BR)DSS}$ , and the drain-to-source On resistance  $R_{DS(ON)}$ .

The maximum continuous drain current,  $I_D$ , rating must be exceed the maximum continuous load current. The rating for the maximum current through the body diode,  $I_S$ , is typically rated the same as, or slightly higher than the drain current, but body diode current only flows while the MOSFET gate is being charged to  $V_{GS(TH)}$ :

Gate Charge Time =  $Q_g / I_{GATE(ON)}$ 

The maximum drain-to-source voltage, V<sub>DS(MAX)</sub>, must be high enough to withstand the highest differential voltage seen in the application. This would include any anticipated fault conditions.

The drain-to-source reverse breakdown voltage,  $V_{(BR)DSS}$ , may provide some transient protection to the OUT pin in low voltage applications by allowing conduction back to the IN pin during positive transients at the OUT pin.

The gate-to-source threshold voltage,  $V_{GS(TH)}$ , should be compatible with the LM5050 gate drive capabilities. Logic level MOSFETs are recommended, but sub-Logic level MOSFETs can also be used.

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The dominate MOSFET loss for the LM5050 active OR-ing controller is conduction loss due to source-to-drain current to the output load, and the  $R_{DS(ON)}$  of the MOSFET. This conduction loss could be reduced by using a MOSFET with the lowest possible  $R_{DS(ON)}$ . However, contrary to popular belief, arbitrarily selecting a MOSFET based solely on having low  $R_{DS(ON)}$  may not always give desirable results for several reasons:

1) Reverse transition detection. Higher  $R_{DS(ON)}$  will provide increased voltage information to the LM5050 Reverse Comparator at a lower reverse current level. This will give an earlier MOSFET turn-off condition should the input voltage become shorted to ground. This will minimize any disturbance of the redundant bus.

2) Reverse current leakage. In cases where multiple input supplies are closely matched it may be possible for some small current to flow continuously through the MOSFET drain to source (i.e. reverse) without activating the LM5050 Reverse Comparator. Higher R<sub>DS(ON)</sub> will reduce this reverse current level.

3) Cost. Generally, as the R<sub>DS(ON)</sub> rating goes lower, the cost of the MOSFET goes higher.

Selecting a MOSFET with an  $R_{DS(ON)}$  that is too large will result in excessive power dissipation. Additionally, the MOSFET gate will be charged to the full value that the LM5050 can provide as it attempts to drive the Drain to Source voltage down to the  $V_{SD(REG)}$  of 20 mV typical. This increased Gate charge will require some finite amount of additional discharge time when the MOSFET needs to be turned off.

As a guideline, it is suggest that  $R_{DS(ON)}$  be selected to provide at least 20 mV, and no more than 100 mV, at the nominal load current.

 $(20 \text{ mV} / \text{I}_{\text{D}}) \le \text{R}_{\text{DS(ON)}} \le (100 \text{mV} / \text{I}_{\text{D}})$ 

The thermal resistance of the MOSFET package should also be considered against the anticipated dissipation in the MOSFET in order to ensure that the junction temperature ( $T_J$ ) is reasonably well controlled, since the  $R_{DS(ON)}$  of the MOSFET increases as the junction temperature increases.

$$P_{DISS} = I_D^2 x (R_{DS(ON)})$$

Operating with a maximum ambient temperature ( $T_{A(MAX)}$ ) of 35°C, a load current of 10A, and an  $R_{DS(ON)}$  of 10 m $\Omega$ , and desiring to keep the junction temperature under 100°C, the maximum junction-to-ambient thermal resistance rating ( $\theta_{JA}$ ) would need to be:

| $\theta_{JA} \leq (T_{J(MAX)} - T_{A(MAX)})/(I_D^2 \times R_{DS(ON)})$ | (6) |
|------------------------------------------------------------------------|-----|
| θ <sub>JA</sub> ≤ (100°C - 35°C)/(10A x 10A x 0.01Ω)                   | (7) |
| θ <sub>JA</sub> ≤ 65°C/W                                               | (8) |



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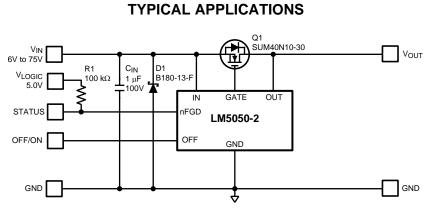


Figure 23. Basic Application with Input Transient Protection

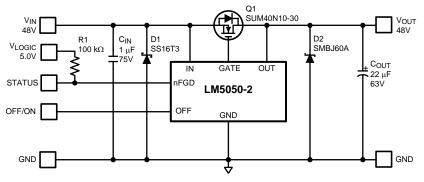


Figure 24. Typical +48V Application with Transient Protection

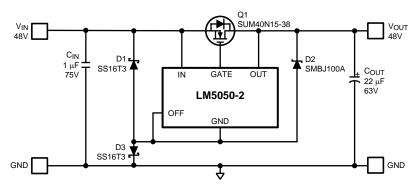


Figure 25. +48V Application with Reversed Input Voltage ( $V_{IN}$  = -48V) Protection

# **REVISION HISTORY**

| Cł | nanges from Revision A (March 2013) to Revision B  | Pa | ge |
|----|----------------------------------------------------|----|----|
| •  | Changed layout of National Data Sheet to TI format |    | 15 |



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## PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package   Pins            | Package qty   Carrier | RoHS | Lead finish/  | MSL rating/        | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|---------------------------|-----------------------|------|---------------|--------------------|--------------|--------------|
|                       | (1)    | (2)           |                           |                       | (3)  | Ball material | Peak reflow        |              | (6)          |
|                       |        |               |                           |                       |      | (4)           | (5)                |              |              |
| LM5050MK-2/NOPB       | Active | Production    | SOT-23-<br>THIN (DDC)   6 | 1000   SMALL T&R      | Yes  | SN            | Level-1-260C-UNLIM | -40 to 125   | SZJB         |
| LM5050MK-2/NOPB.A     | Active | Production    | SOT-23-<br>THIN (DDC)   6 | 1000   SMALL T&R      | Yes  | SN            | Level-1-260C-UNLIM | -40 to 125   | SZJB         |
| LM5050MKX-2/NOPB      | Active | Production    | SOT-23-<br>THIN (DDC)   6 | 3000   LARGE T&R      | Yes  | SN            | Level-1-260C-UNLIM | -40 to 125   | SZJB         |
| LM5050MKX-2/NOPB.A    | Active | Production    | SOT-23-<br>THIN (DDC)   6 | 3000   LARGE T&R      | Yes  | SN            | Level-1-260C-UNLIM | -40 to 125   | SZJB         |
| LM5050MKX-2/NOPB.B    | Active | Production    | SOT-23-<br>THIN (DDC)   6 | 3000   LARGE T&R      | -    | SN            | Level-1-260C-UNLIM | -40 to 125   | SZJB         |

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

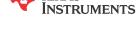
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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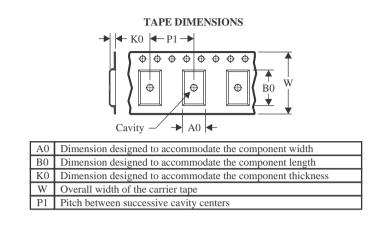


Texas

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# TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal |                 |                    |   |      | 0                        |                          |            |            |            | r.         |           | t.               |
|-----------------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device                      | -               | Package<br>Drawing |   | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
| LM5050MK-2/NOPB             | SOT-23-<br>THIN | DDC                | 6 | 1000 | 178.0                    | 8.4                      | 3.2        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| LM5050MKX-2/NOPB            | SOT-23-<br>THIN | DDC                | 6 | 3000 | 178.0                    | 8.4                      | 3.2        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |



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# PACKAGE MATERIALS INFORMATION

9-Aug-2022



\*All dimensions are nominal

| Device           | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| LM5050MK-2/NOPB  | SOT-23-THIN  | DDC             | 6    | 1000 | 208.0       | 191.0      | 35.0        |
| LM5050MKX-2/NOPB | SOT-23-THIN  | DDC             | 6    | 3000 | 208.0       | 191.0      | 35.0        |

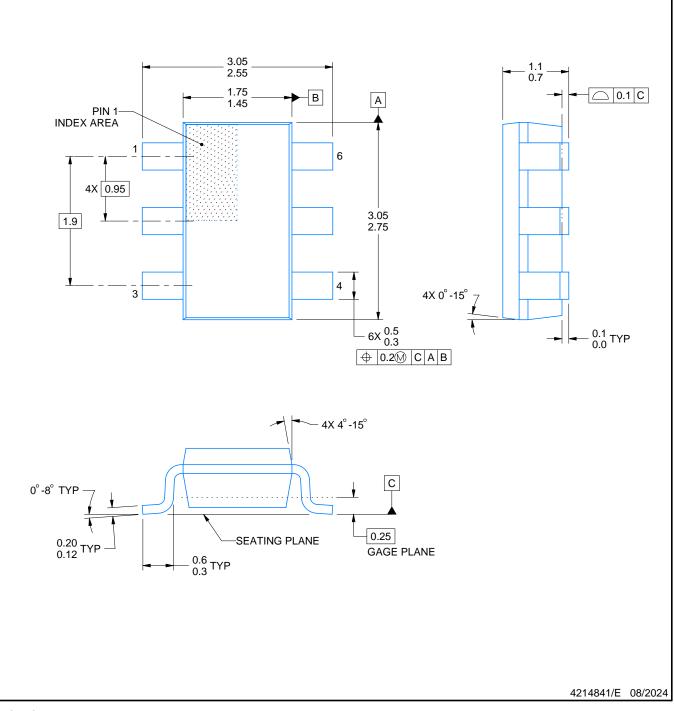
# **DDC0006A**



# **PACKAGE OUTLINE**

# SOT-23 - 1.1 max height

SMALL OUTLINE TRANSISTOR



NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  This drawing is subject to change without notice.
  Reference JEDEC MO-193.

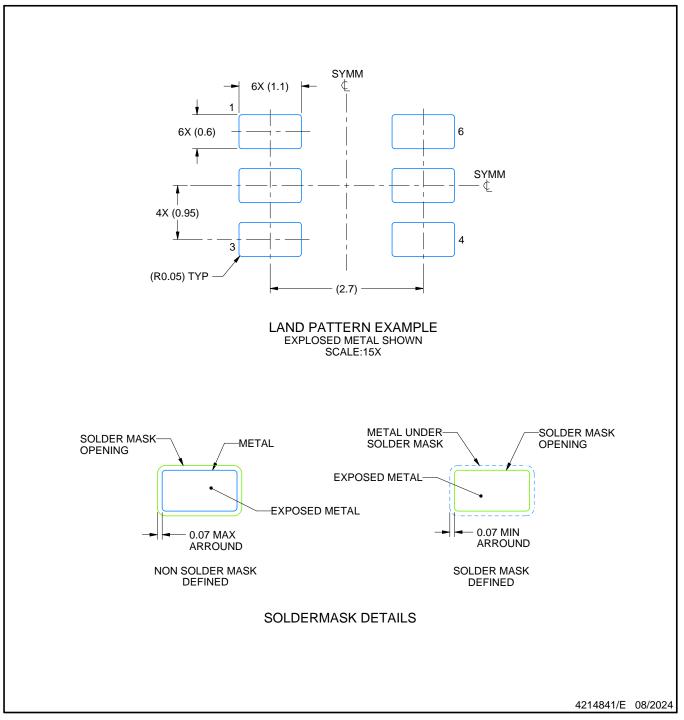


# **DDC0006A**

# **EXAMPLE BOARD LAYOUT**

# SOT-23 - 1.1 max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

4. Publication IPC-7351 may have alternate designs.

5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

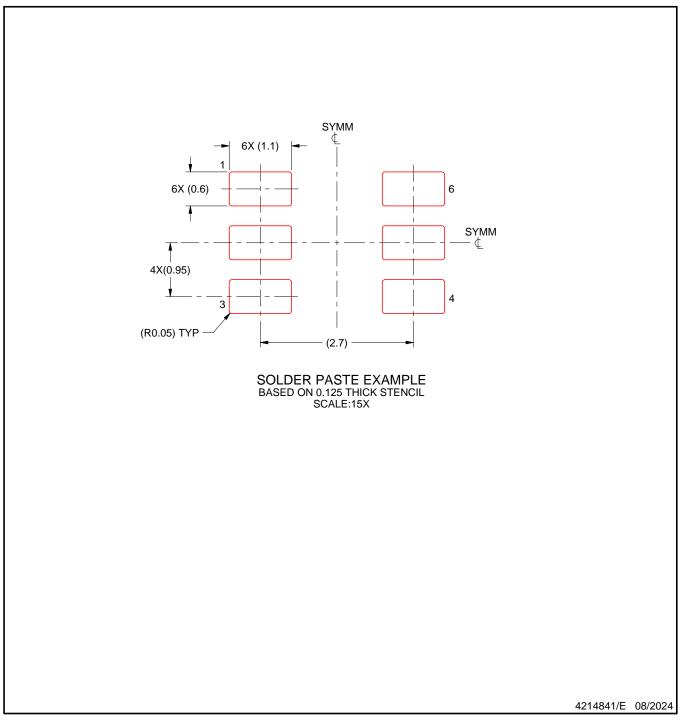


# **DDC0006A**

# **EXAMPLE STENCIL DESIGN**

# SOT-23 - 1.1 max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations. 7. Board assembly site may have different recommendations for stencil design.



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